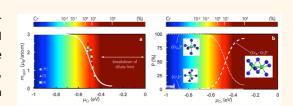
Atomic-Scale Magnetism of Cr-Doped Bi₂Se₃ Thin Film Topological Insulators

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ABSTRACT Magnetic doping is the most common method for breaking timereversal-symmetry surface states of topological insulators (TIs) to realize novel physical phenomena and to create beneficial technological applications. Here we present a study of the magnetic coupling of a prototype magnetic TI, that is, Cr-doped Bi₂Se₃, in its ultrathin limit which is expected to give rise to quantum anomalous Hall (QAH) effect. The high quality Bi_{2-x}Cr_xSe₃ epitaxial thin film was



prepared using molecular beam epitaxy (MBE), characterized with scanning transimission electron microscopy (STEM), electrical magnetotransport, and X-ray magnetic circularly dichroism (XMCD) techniques, and the results were simulated using density functional theory (DFT) with spin—orbit coupling (SOC). We observed a sizable spin moment $m_{\rm spin}=(2.05\pm0.20)~\mu_{\rm B}/{\rm Cr}$ and a small and negative orbital moment $m_{\rm orb}=(-0.05\pm0.02)~\mu_{\rm B}/{\rm Cr}$ of the Bi_{1.94}Cr_{0.06}Se₃ thin film at 2.5 K. A remarkable fraction of the $({\rm Cr_{Bi}-Cr_I})^{3+}$ antiferromagnetic dimer in the Bi_{2...x}Cr_xSe₃ for 0.02 < x < 0.40 was obtained using first-principles simulations, which was neglected in previous studies. The spontaneous coexistence of ferro- and antiferromagnetic Cr defects in Bi_{2...x}Cr_xSe₃ explains our experimental observations and those based on conventional magnetometry which universally report magnetic moments significantly lower than 3 $\mu_{\rm B}/{\rm Cr}$ predicted by Hund's rule.

KEYWORDS: magnetic topological insulator · spin and orbital moments · XMCD · density functional theory · spintronics

hree-dimensional topological insulators (TIs) represent unusual phases of quantum matter with an insulating bulk gap and gapless Dirac-like band dispersion surface states. Unlike the different electronic properties of the surface and the bulk universally existing in all solids owing to the inevitable termination of the periodic lattice structure near the surface. TIs present a new class of nontrivial surface states arising from the intrinsic strong SOC. These robust low-dimensional conducting states are topologically protected against timereversal-invariant perturbations, such as scattering by nonmagnetic impurities, crystalline defects, and surface distortions. While such a phase offers unique opportunities for fundamental research, it is equally important to break the time-reversal symmetry of TIs to realize novel physical phenomena and quantum-computing applications. The newly demonstrated QAH effect, 1-3

abnormal proximity effect, 4,5 giant magnetooptical Kerr effect, ⁶ magnetic monopole, ⁷ and chiral conduction channels^{8,9} are some of the fascinating examples. Within the growing family of Tls, ferromagnetism has been reported in V-, Cr-, and Mn-doped single crystals of Sb₂Te₃, 10,11 Fe- and Mn-doped single crystals of Bi₂Te₃, 12,13 and Mn-doped single crystals of Bi₂Se₃.¹⁴ Both ferro-¹⁵ and antiferromagnetism¹⁶ have been reported in Cr-doped Bi₂Se₃, and for Fe-doped Bi₂Se₃ observations are rather controversial. Zhang et al. 17 studied the effect of magnetic doping of a series of 3d transition metals in Bi₂Se₃ using first-principles calculations and found that Cr and Fe doping preserves the insulating nature of the host TI in the bulk and Cr-doped Bi₂Se₃ is likely to be ferromagnetic. Apart from transition metals, rare-earth metals such as Gd, 18 Dy, and Sm 19 have also been explored as an effective dopant to induce long-range magnetic ordering in Bi₂Se₃²⁰ or Bi₂Te₃.

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TABLE 1. Reported Experimental Values for the Magnetic Moment of Magnetically Doped Bi₂Se₃

system	method	\emph{m}_{total} (μ_{B} /atom)	ref this work	
Bi _{1.94} Cr _{0.06} Se ₃	XMCD	2.00 ± 0.20		
$Bi_{1.98}Cr_{0.02}Se_3$	SQUID-VSM	0.4	18	
$Bi_{1.76}Cr_{0.24}Se_3$	neutron scattering	1.5	24	
$Bi_{1.90}Cr_{0.1}Se_3$	SQUID-VSM	2.0	15	
$Bi_{1.77}Cr_{0.23}Se_3$	XMCD	2.9 ± 0.3	21	
$Bi_{1.98}Mn_{0.02}Se_3$	SQUID-VSM	1.5	14	
$Bi_{1.995}Fe_{0.005}Se_3$	SQUID-VSM	3.2	14	
$Bi_{1.98}Gd_{0.02}Se_3$	SQUID-VSM	6.9 ± 0.2	18	

For the electronic and magnetic ground state of the magnetically doped TIs, evidence from the experimental observations including magneto-transport measurements, 49,50 global magnetometry, 14,15,49 and corelevel spectroscopies^{21–23} are so far inconclusive. Magnetic studies on epitaxial, Cr-doped Bi₂Se₃ using superconducting quantum interference device-vibrating sample magnetometer magnetometry (SQUID-VSM)¹⁵ and polarized neutron reflectometry (PNR)²⁴ universally reported a magnetic moment of no more than \sim 2 $\mu_{\rm B}$ /atom, remarkably lower than the Hund's rule of 3 $\mu_{\rm B}/{\rm atom}$ of substitutional ${\rm Cr^{3+}}$ on Bi sites. Significant mismatch also exists in Mn- and Fe-doped Bi₂Se₃, who typically show global magnetic moments of \sim 1.5 and \sim 3 $\mu_{\rm B}$ /atom, ¹⁴ while their Hund's rule is 5 $\mu_{\rm B}$ /atom. Table 1 gathers the magnetic moment of Bi₂Se₃ for various magnetic dopants. It has been proposed that in magnetic Tls, ferromagnetic moments can be developed not only through the s-d exchange interaction such as in diluted magnetic semiconductors (DMSs), 25-29 but also through the van Vleck mechanism, by which magnetic ions are directly coupled through the local valence elecrons.³ Both types of mechanism have been observed independently in Mn-doped Bi₂(TeSe)₃³⁰ and Cr-doped (BiSb)₂Te₃³¹ thin films. Given the fact that the magnetic state of a doped TI can be independent of the carrier concentration, it is timely and important to obtain an insight of the detailed chemical bonds of the magnetic impurities. In this regard, the synchrotron-based technigues of XMCD are ideal valence-, site-, and symmetryspecific probes.^{32,23,33–37} In this paper, we present a comprehensive study of magnetism of a prototypical magnetic TI, i.e., Bi_{2-x}Cr_xSe₃, in its ultrathin limit which is expected to give rise to QAH effect.³ According to the pioneering work by Haazen et al.,15 the magnetic moment of Bi_{2-x}Cr_xSe₃ decreases with increasing doping concentration and sharply drops beyond \sim 10%. On the other hand, excessively low Cr concentrations, that is, <1%, form no long-range magnetic ordering. 49 Therefore, we selected a 3% Cr-doped Bi₂Se₃ or Bi_{1,94}Cr_{0,06}Se₃ thin film to perform the detailed XMCD study. Using XAS and XMCD, we quantitatively addressed the magnetic moments of the epitaxial Bi_{1.94}Cr_{0.06}Se₃ thin film, and the results were compared with first-principle calculations to get an insight of the nature of the magnetic coupling.

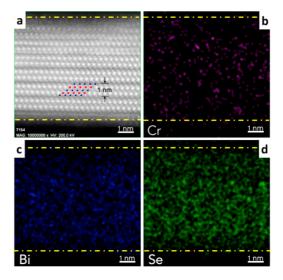


Figure 1. STEM characterization. (a) Typical HAADF image showing the highly ordered hexagonal and quintuple layer structure of the prepared $Bi_{2-x}Cr_xSe_3/Si(111)$ thin film samples. The red and blue dots represent the Bi and Se columns, respectively, within one quintuple layer. The dash-dotted lines indicate the boundaries of the $Bi_{2-x}Cr_xSe_3$ thin film with the Al_2O_3 cap and the Si substrate, respectively. (b—d) EDX color maps of (b) Cr_r (c) Bi_r and (d) Se_r

RESULTS AND DISCUSSION

The 10 nm $Bi_{1.94}Cr_{0.06}Se_3/Si(111)$ thin films used in this study was prepared using MBE. First the crystalline structure of the prepared samples was characterized using high-angle annular dark-field (HAADF) highresolution STEM. Cross-sectional foils of Bi_{1.94}Cr_{0.06}Se₃/ Si(111) were prepared by focused ion beam (FIB), during which all parameters were carefully optimized to avoid ion injection and specimen damage, including the accelerating voltage, beam current, and tilt angle.4 Figure 1a presents a typical HAADF image of the $Bi_{1.94}Cr_{0.06}Se_3/Si(111)$, in which the Bi and Se columns (marked by red and blue solid circles, respectively) can be clearly identified owing to the Z-contrast sensitivity of the HAADF imaging technique. The dark regions outside Bi_{1.94}Cr_{0.06}Se₃ corresponds to the Al₂O₃ cap and Si substrate, respectively, which cannot be demonstrated using the present mode since they are composed of much lighter atoms than Bi and Se. The Cr dopants are uniformly distributed within the Bi₂Se₃ film, as can be seen from the EDX color maps of the Cr, Bi, and Se, respectively, in Figure 1b-d. Overall, the HAADF images confirm the highly ordered hexagonal and quintuple-layered structure of the prepared Bi_{1.94}Cr_{0.06}Se₃/Si(111) thin films without appreciable Cr segregations or secondary phases.^{38,39} It should be noted that even though these images solely are not sufficient to evidence the entry modes of the Cr dopants in the Bi₂Se₃ matrix for the similar reason as the inaccessibility of the Al atoms.

The global magnetic response of the epitaxial $Bi_{1.96}Cr_{0.06}Se_3/Si(111)$ thin film samples was examined by magneto-transport measurements by patterning

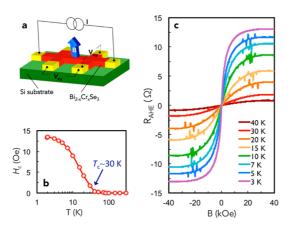
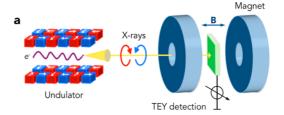


Figure 2. Electrical magneto-transport measurements. (a) Schematic diagram of the experimental setup of the QAH effect measurement. (b) $H_{\rm c}$ versus temperature of the Bi_{1.94}Cr_{0.06}Se₃/Si(111) thin film from 3 to 300 K. (c) $R_{\rm AHE}$ versus magnetic field B of the thin film from 3 to 40 K after background removal.

into standard Hall bar devices, using conventional optical photolithography and a subsequent CHF₃ dry etching for 20 s. As shown in Figure 2a, six Hall channel contacts (10 nm Ti and 100 nm Au) were defined by e-beam evaporation. Standard four-terminal electrodes were fabricated to eliminate the contact resistance. A constant AC current of $0.05-0.1 \mu A$ with a frequency of 1.3 kHz is fed through two outer contacts, and the voltage drop across the inner pads is measured to determine the resistance. By subtracting the ordinary Hall component, we plotted the anomalous Hall resistance $(R_{\text{AHE}} = R_{xy} \sim R_0 H)^{40}$ as a function of the field applied perpendicularly to the film in Figure 2c, in which a nonzero $R_{\rm AHE}$ was observable up to \sim 30 K. Figure 2b presents the temperature dependence of the coercive field (H_c) estimated from the shift of the weak antilocalization (WAL) cusp under the opposite field scanning directions. 4,49 The H_c exhibits Curie-like behavior against the temperature and $T_c \approx$ 30 K, consistent with that estimated from R_{AHE} .

X-ray absorption spectroscopy (XAS) measurements at the Cr L_{2,3} absorption edge of the Bi_{1.96}Cr_{0.06}Se₃/ Si(111) thin film were performed on beamline I10 at the Diamond Light Source, U.K. Circularly polarized X-rays with \sim 100% degree of polarization⁴¹ were used in normal incidence with respect to the sample plane and parallel to the applied magnetic field, as illustrated in Figure 3a. The XMCD was obtained by taking the difference of the XAS spectra, that is, $\sigma^- - \sigma^+$, by flipping the X-ray helicity at a fixed magnetic field of 30 kOe, under which the sample is fully magnetized with negligible paramagnetic contribution.^{4,49,50} Figure 3b presents a typical pair of XAS and XMCD spectra of the Bi_{1.96}Cr_{0.06}Se₃/Si(111) epitaxial thin film obtained at 2.5 K using total electron yield detection (TEY). The XAS of Cr shows multiple structures for both spin-orbit split core levels, suggesting a mixture of Cr with more than one valence state. This mixture can be analyzed



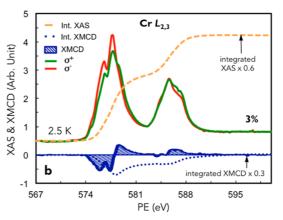


Figure 3. XAS/XMCD measurements. (a) Schematic diagram of the experimental setup for XAS and XMCD at the beamline, where the beamline optics has been omitted. (b) Typical pair of XAS and XMCD spectra of the Bi_{1.94}Cr_{0.06}Se₃/Si(111) thin film. Data are offset and scaled for clarity.

using atomic multiplet simulation of the spectrum as detailed in the Supporting Information, which indicates that the Cr dopants are primarily near-trivalent and the presence of a small amount of divalent Cr is most likely from the terminated surface of the ${\rm Bi}_{2-x}{\rm Cr}_x{\rm Se}_3$ lattice. 21,22

The spin $(m_{\rm spin})$ and orbital $(m_{\rm orb})$ magnetic moment of the Bi_{1.96}Cr_{0.06}Se₃/Si(111) thin film were obtained by applying the sum rules^{42,43} to the integrated XMCD and summed XAS spectra of the Cr $L_{2,3}$ edges, based on

$$m_{1} = -\frac{4}{3} n_{h} \frac{\int_{L_{2,3}} (\sigma^{-} - \sigma^{+}) dE}{\int_{L_{2,3}} (\sigma^{-} + \sigma^{+}) dE}$$

$$m_{s} = -n_{h} \frac{6 \int_{L_{3}} (\sigma^{-} - \sigma^{+}) dE - 4 \int_{L_{2,3}} (\sigma^{-} - \sigma^{+}) dE}{\int_{L_{2,3}} (\sigma^{-} + \sigma^{+}) dE} \times SC - \langle T_{z} \rangle$$
(1)

where E, $n_{\rm hr}$, SC, and $\langle T_z \rangle$, represent the photon energy, number of d holes, spin correction (SC) factor, and magnetic dipole term, respectively. In order to exclude the nonmagnetic contribution of the XAS spectra an arctangent-based step function is used to fit the threshold. The spectral overlap or j-j mixing has to be taken into account because of the relatively small spin—orbit splitting in the Cr 2p level. The value of SC, that is, 2.0 ± 0.2 for Cr, was determined by calculating the $L_{2,3}$ multiplet structure for a given ground state, applying the sum rule on the calculated XMCD spectrum, and comparing the result with the

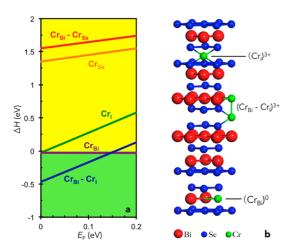


Figure 4. Cr-related defects in $Bi_{2-x}Cr_xSe_3$. (a) Formation energy ΔH of the Cr-related defects in $Bi_{2-x}Cr_xSe_3$ obtained under the given growth conditions as described in the text. The slopes indicate the stable charge states of the defect, and the zero of E_F corresponds to the valence band maximum (VBM). (b) Illustration of the three types of predominant defects in $Bi_{2-x}Cr_xSe_3$, i.e., Cr_B^{-0} , Cr_1^{-3+} , and $(Cr_{Bi}-Cr_I)^{3+}$.

spin moment calculated directly for this ground state. 5,46 Assuming $n_h = 7$ on the majority trivalent Cr basis (see the Supporting Information), we obtained $m_{\rm spin}$ = (2.05 \pm 0.20) $\mu_{\rm B}$ /atom and $m_{\rm orb}$ = (-0.05 \pm 0.02) for the $Bi_{1.94}Cr_{0.06}Se_3/Si(111)$ thin film. That gives a total moment ($m_{
m total}$) of (2.00 \pm 0.20) $\mu_{
m B}$ /atom as included in Table 1. The $m_{\rm orb}$ and $m_{\rm spin}$ have opposite signs, corresponding to an antiparallel alignment of spin and orbital moments in Cr. This agrees with the Hund's rule for Cr where the 3d shell is less than half full. The octahedral crystal-field interaction quenches $m_{\rm orb}$, because the 3d electrons occupy the 3-fold degenerate majority-spin t_{2q} orbitals, leading to a nearly vanishing $m_{\rm orb}$ as observed here. For similar reasons the $\langle T_z \rangle$ is small and is not taken out from the $m_{\rm spin}$, giving an error <5%.

We address the origin of the observed m_{spin} and $m_{\rm orb}$ of the Bi_{1.94}Cr_{0.06}Se₃/Si(111) thin film to this end. The layered structure of Bi₂Se₃ allows the Cr dopants not only to enter the host substitutionally, but also interstitially in the van der Waals gap between the layers. To investigate the $m_{\rm spin}$ and $m_{\rm orb}$ of Cr in Bi₂Se₃, it must first be determined where the Cr prefers to reside within the lattice. Although several prior works 17 have reported that substitutional Cr is energetically more favorable over interstitial Cr, if one considers only single impurities, these calculations leave out the possibility of the presence of complex defects. We calculated the formation energies (ΔH) of Cr at various lattice positions including not only the interstitial (denoted as Cr_I) and substitutional sites with Cr replacing Bi (denoted as CrBi) and Se (denoted as CrSe), but also the large defect complexes containing pairs of Cr-atoms, such as the Cr_{Bi}-Cr_{Se} and Cr_{Bi}-Cr_I. As illustrated in Figure 4b, the predominant defects in the system were found to be Cr_I³⁺, Cr_{Bi}⁰, and (Cr_{Bi}-Cr_I)³⁺

TABLE 2. Calculated Magnetic Moments of the Low-Energy Cr Related Defects in Bi_2Se_3 and That Derived from XMCD Measurements As Described in the Text^a

		ΔH	$m_{\rm spin}$	$m_{ m orb}$	$m_{ m total}$
Cr defect	method	(eV)	($\mu_{\rm B}/{ m atom}$)	(μ_{B} /atom)	(μ_{B} /atom)
3%	XMCD		2.05 ± 0.20	-0.05 ± 0.02	2.00 ± 0.20
3%	PBE		1.90	-0.03	1.87
Cr _I ³⁺	PBE	-0.03	2.98	-0.03	2.95
Cr_{Bi}^{0}	PBE	-0.21	2.93	-0.02	2.91
$(Cr_I - Cr_{Bi})^{3+}$	PBE	-0.68	0.01	-0.04	-0.03

^a The calculated results include SOC and correspond to the $E_{\rm F}$ at the CBM with $\mu_{\rm Cr}$ and $\mu_{\rm Bi}$ equal to their respective bulk values.

complex whose calculated ΔH , excluding SOC, for Fermi energies (E_F) ranging from the valence band maximum (VBM) to the conduction band minimum (CBM) are presented in Figure 4a. We ruled out the possibilities of Cr_{Se} and Cr_{Se} – Cr_{Bi} as the ΔH of them was found to be high (>1 eV). Table 2 presents the ΔH and the magnetic moments of the three low-energy defects, namely, Cr_{I} , Cr_{Bi} , and Cr_{Bi} – Cr_{I} calculated including SOC. While both Cr_{Bi} and Cr_{I} have m_{spin} of \sim 3 $\mu_{\rm B}/{\rm atom}$, the Cr_{Bi}-Cr_I pair is antiferromagnetic (with the high-spin magnetic configuration 75 meV higher in energy) with a nearly vanished $m_{\rm spin}$. In consistent with the XMCD-derived $m_{\rm orb}$, the calculation also gives small and negative $m_{\rm orb}$ for the Cr dopants due to the effect of the crystal field. This indicates that Cr retains its small SOC nature, even when incoopertaed into a strong SOC system like Bi₂Se₃.

Figure 5 presents the dependence of the Cr content, average magnetic moment, and the relative concentrations, respectively, of the most common Cr related defects as a function of the chemical potential of Cr with the $E_{\rm F}$ pinned at the CBM. While the antiferromagnetic Cr_{Bi}—Cr_I pair is the dominant defect for large Cr concentrations, as the Cr chemical potential decreases (and hence the amount of incorporated Cr), entropy works against the pair formation, and Cr_{Bi} becomes the dominant defect. This can be seen in Figure 5b, which shows the relative probabilities of the different defects as a function of m_{Cr} which was calculated by minimizing the free energy of the system with respect to the number of defects (see the Supporting Information). It should be noted that the position of the crossover between the stability of the Cr_{Bi} and Cr_{Bi}-Cr_I defects, depicted in Figure 5b, depends on the $m_{\rm Bi}$. As we tend toward Se-rich growth conditions, CrBi becomes the dominant defect for all Cr concentrations. We treated the m_{Bi} as a fitting parameter and find that the observed data for $m_{\rm spin}$ can be best described when $m_{\rm Bi} \approx 150$ meV below $m_{\rm Bi}^{\rm bulk}$. This proximity to the Birich condition is well observed in MBE grown samples which typically have high Se vacancy concentrations, despite their high Se deposition rates. 49,50 The dependence of the average magnetic

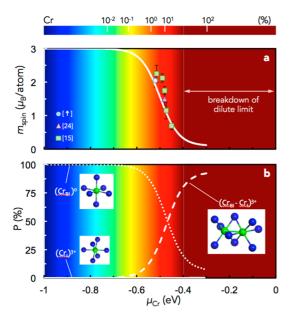


Figure 5. Dependence of (a) $m_{\rm spin}$ and (b) the fraction of the three predominant defects ${\rm Cr_l}^{3+}, {\rm Cr_{Bi}}^0$, and $({\rm Cr_{Bi}-Cr_l})^{3+}$, as a function of the chemical potential of ${\rm Cr}$ ($\mu_{\rm Cr}$). The zero point of the $\mu_{\rm Cr}$ is that of bulk Cr and $\mu_{\rm Bi}$ is 150 meV below that of $\mu_{\rm Bi}^{\rm bulk}$. The uppermost scale is an indication of the Cr doping concentration as defined in the text. The brown coloring corresponds to very high defect concentration, in and near where the dilute approximation dramatically fails. The experimentally measured $m_{\rm spin}$ of ${\rm Bi}_{2-x}{\rm Cr}_x{\rm Se}_3$ with varing x have been taken from the literature and gathered in (a) in comparison with the calculation. Dagger symbol (†) refers to this work. Note our definition of the doping concentration differs by a factor of \sim 2.5 that by Hazzen et al.; hence, the numbers quoted here are larger than that presented in the original paper. 15

moment per Cr is shown in Figure 5a. The change in stability between Cr_{Bi} and the Cr_{Bi} — Cr_I pair leads to an average magnetic moment which explictly depends on the Cr chemical potential. In agreement with the ponieering reports by Zhang et al., ^{17,47} we found that Bi substitutional sites are more stable than interstitial sites for Cr impurities. However, the Cr_{Bi} — Cr_I bonding can significantly alter ΔH , leaving the $(Cr_{Bi}$ — $Cr_I)^{3+}$ complex even lower in energy than either Cr_{Bi} or Cr_I for high Cr doping concentrations. The spontaneous coexistence of ferro- and antiferromagnetic Cr in

 $Bi_{2-x}Cr_xSe_3$ explains not only the experimental results of our work based on XMCD, but also observations such as by Haazen et al. Using SQUID-VSM and by Collins-McIntyre et al. Using PNR, who both reported mismatches between the observed magnetic moment of $Bi_{2-x}Cr_xSe_3$ and the Hund's rule value of 3 μ_B /atom for substitutional Cr^{3+} on Bi sites. In consistent with the pioneering experimental reports, 5,49,50 we found that the growth temperature varying between 200 and 300 °C results in no significant difference of the type and distribution the Cr-related defects while below 200 °C, more antiferro-magnetic Cr defects can presence.

CONCLUSIONS

To summarize, we have presented a comprehensive study of the Cr $m_{\rm spin}$ and $m_{\rm orb}$ of a prototype magnetic TI, that is, $Bi_{2-x}Cr_xSe_3$, in the ultrathin limit which is expected to give rise to QAH effect. The high quality Bi_{1.94}Cr_{0.06}Se₃/Si(111) epitaxial thin film was prepared using MBE, carefully characterized with STEM, magnetotransport and XMCD measurements. We have quantitatively addressed the $m_{\rm spin}$ and $m_{\rm orb}$ of the Bi_{2-x}Cr_xSe₃/Si(111) thin films and the results agree well with DFT caculations. The XMCD-derived $m_{\rm spin}$ is remarkably lower than Hund's rule value and the m_{orb} is negative and largely quechhed. We obtained a remarkable fraction of the $(Cr_{Bi}-Cr_I)^{3+}$ antiferromagnetic dimers in $Bi_{2-x}Cr_xSe_3$ for 0.02 < x < 0.40, which has been neglected in previously reported studies. The spontaneous coexistence of ferro- and antiferro-magnetic Cr defects in Bi_{2-x}Cr_xSe₃ explains the experimental observations of this work as well as those based on conventional magnetometry that universally report magnetic moments significantly lower than that predicted by the Hund's rule. Our work provides direct evidence for the detailed magnetic states of the magnetically doped TIs in thin film form. Future work to explore the tuning of the magnetization of TIs and its dependence on the band filling will have strong implications for both fundamental physics and emerging spintronics technology.

METHODS

Sample Preparations. The 10 nm $\mathrm{Bi}_{2-x}\mathrm{Cr}_x\mathrm{Se}_3$ thin films used in this study were grown in ultrahigh vacuum (UHV) using a PerkinElmer MBE system on Si(111) substrates using the well-established recipe. High-purity Bi (99.9999%) was evaporated from conventional effusion cells at 470 °C, while Se (99.999%) was created from a cracker cell (SVTA) at 240 °C. The substrates were preannealed at 200 °C in UHV until the two-dimensional streak pattern appeared as monitored by the real-time reflection high-energy electron diffraction (RHEED). The desired doping concentrations of Cr were obtained by evaporating Cr (99.99%) from the effusion cell at different temperatures and calibrated by energy dispersive X-ray analysis. Immediately after the growth of the $\mathrm{Bi}_{1.94}\mathrm{Cr}_{0.06}\mathrm{Se}_3$ thin film, 2 nm Al was *in situ* evaporated onto the sample to protect it

from oxidation and environmental doping during transport to the synchrotron facility.

ΔH Calculations. The *first-principles* DFT calculations were performed within the Perdew—Burke—Ernzerhof (PBE) generalized gradient approximation (GGA).⁵¹ The Bi (*5d*, 6*s*, 6*p*), Se (4*s*, 4*p*), and Cr (3*p*, 3*d*, 4*s*) orbitals are explicitly treated in the valence and interactions between the ion cores and valence electrons are described by the projector augmented wave (PAW)^{52,53} method as implemented in the VASP code.^{54,55} Since SOC has shown to be important to describe the defect properties of Bi₂Se₃,⁵⁶ the magnetic properties and formation energies of the low energy defects were also calculated with SOC implemented in the all-electron part of the PAW Hamiltonian within the muffin-tin spheres. The basis set consisted of plane waves with a kinetic energy cutoff of 270 eV and the total energy was calculated with a Brillouin zone sampling of

 $2\times2\times2.^{57}$ Structural relaxations of the defects were performed in a 4 \times 4 supercell containing 3 quintuple layers (QLs) with 95 Bi and 145 Se atoms and proceeded until the largest Hellmann–Feynman force was less than 0.025 eV/A. The ΔH of the defects were calculated in the low-density limit according to

$$\Delta H = E(D^q) - E_{\text{bulk}} + \sum_{i} \Delta n_i \mu + q(E_F + E_{VBM})$$
 (2)

where $E(D^q)$, E_{bulk} , μ_i , and Δn_i , respectively, represent the energy of the supercell containing the defect in charge state q, the energy of the defect-free bulk supercell, the chemical potential of the ith atomic species, and the number of those which has changed in the formation of the defect. ⁵⁸

Conflict of Interest: The authors declare no competing financial interest

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Multiplet calculations and ab initio calculations (PDF)

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